

Search Notes

Application/Control No.

10/034,477

Examiner

Susan F. Rayyan

Applicant(s)/Patent under
Reexamination

MEGIDDO ET AL.

Art Unit

2167

SEARCHED

Class	Subclass	Date	Examiner
707	2-6,10,100 101,102 104.1	12/8/2006	SR
709	201	12/8/2006	SR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
707	3,10 100	12/8/2006	SR
707	102	12/8/2006	SR
709	201	12/8/2006	SR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated East Search	12/8/2006	SR
EIC Search: Fast and Focused	12/8/2006	SR
Inventors' Name Search	12/8/2006	SR
ACM	12/8/2006	SR
IEEE		